

# **HIGH RESOLUTION**

**342 720 PHASE POINTS** 

## **HIGH ACCURACY**

WAVEFRONT SENSOR

### COMPACT

**ROBUST AND VERSATILE** 

## **EASY TO USE**

AND INTEGRATE



# **WELCOME TO LIFT ERA**

All the advantages of Shack Hartmann technology combined with the power of phase retrieval

# A UNIQUE SET OF ADVANTAGES

- Ultra high spatial resolution
- Wavefront sensor on the latest CMOS camera for the 400 800 nm range
- 680 x 504 sampling points over a 13.77 mm x 10.22 mm sensing area
- እ/100 rms absolute accuracy or ≥6 nm RMS <sup>(1)</sup>
- 30 Hz acquisition frequency\*
- External trigger capability

- eliminates alignment Tracker requirements.
- Patented technology for simultaneous and independent measurements of phase and intensity
- **USB 3.0 connectivity**
- WaveKit (SDK) available in C/C++, LabVIEW and Python
- Compatible with R-Flex2 and R-Flex LA for optics alignment and characterization

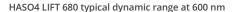


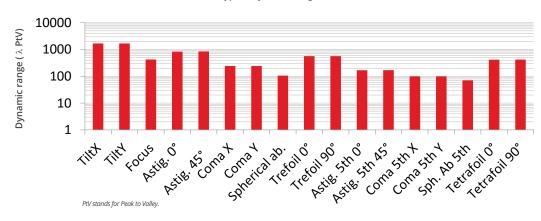
# HASP<sub>680</sub>

#### HIGH SPATIAL SAMPLING WAVEFRONT SENSOR

Providing outstanding performance, the HASO wavefront sensor family is used worldwide in the most demanding applications in optical metrology, industrial control, microscopy and laser diagnostics. Developed from the design of HASO4 126 VIS, the HASO LIFT 680 is as powerful as its counterpart in terms of accuracy and dynamic range, while offering an unequaled resolution of 680 x 504 phase points. This allows the HASO LIFT 680 to provide high-level of performance for applications requiring high accuracy, high dynamic range and high spatial resolution.

- $\lambda/100$  rms absolute accuracy on a huge dynamic range (see the graph below)
- 342 720 phase point resolution on 13.77 x 10.22 mm<sup>2</sup>
- Measurement up to 64 Zernike polynomials with individual accuracy better than 1 nm RMS
- Spot Tracker provides easy HASO alignment and the capability to precisely follow absolute tilt/wavefront evolution over time





### **EXAMPLES OF APPLICATIONS**

- Perfect for freeform optics, aspheric mirrors and meta-optics
- High and middle frequencies mirror surface characterization
- Optical manufacturing metrology

### **SOFTWARE**

- WaveView4 is the most advanced wavefront measurement and analysis software. It offers more than 150 features and tools optimized for a wide range of highly demanding applications. WaveView4 development philosophy is based on tens of years of customer feedback, improving the user experience with each version. WaveView4 provides a function to analyze segmented wavefronts and allows autosave for sequence measurements. Modules dedicated to PSF and MTF and M²are available.
- WaveKit is the SDK in C/C++, LabVIEW and Python, providing the basic blocks on which one can build a fully customized software for specific HASO-based applications or WaveView4 data processing routines. WaveKit is available on request.

### **SPECIFICATIONS**

| Aperture dimension            | 13.77 x 10.22 mm <sup>2</sup>       |
|-------------------------------|-------------------------------------|
| Phase sampling                | 680 x 504                           |
| Tilt dynamic range            | ±3°                                 |
| Focus dynamic range           | ± 0.010 m to ± ∞                    |
| Absolute accuracy             | λ/100 or 6 nm rms                   |
| Sensitivity                   | <λ/200 rms                          |
| Spatial resolution            | ~ 20 µm                             |
| Maximum acquisition frequency | 30 Hz                               |
| External trigger              | TTL signal                          |
| Working wavelength range      | 400 - 800 nm                        |
| Dimensions / weight           | 47 x 60 x 62 mm <sup>3</sup> / 200g |
| Working temperature           | 15 - 30 ℃                           |
| Interface / Power consumption | USB 3.0 / 3.6W                      |
| Operating system              | Windows 10                          |
| Minimum power                 | 0.7 nW*                             |

<sup>\*</sup> At 30 Hz, the maximum exposure duration is 33ms